DEVICE ENGINEERING INCORPORATED

Chandler, AZ 85225 Phone: (480) 303-0822 Fax: (480) 303-0824 E-mail: admin@deiaz.com

385 East Alamo Drive

DEI1026 Six Channel Discrete-to-Digital Interface Sensing Open/Ground Signals

Features:

- Senses six Open/Ground Inputs
- Inputs are lightning protected to DO-160D Level 3
- TTL/CMOS-Compatible Tri-State Outputs
- Package / Temperature Options:
 - 16 lead .150" SOIC, -55°C /+85°C
 - 16 lead Ceramic 300mil SOP, -55°C /+125°C



SOIC package option shown

Functional Description:

The DEI1026 is a six channel discrete-to-digital interface BiCMOS device. It senses six Open/Cround discrete signals of the type commonly found in avionic systems. The inverted 3-state outputs are TTL/CMOS compatible and are enabled by the $\overline{\text{OE}}$ and $\overline{\text{CE}}$ pins. The inputs are lightning protected to meet the requirements of DO160D Sec 22 Waveforms 3, 4, and 5, Level 3. See figures 5-7. The device is available in a 16 lead .150 SOIC and .300 Ceramic SOP.

With its reliability, low cost, operating range, and lightning protection, the DEI1026 meets a large variety of interface requirements for aerospace applications.

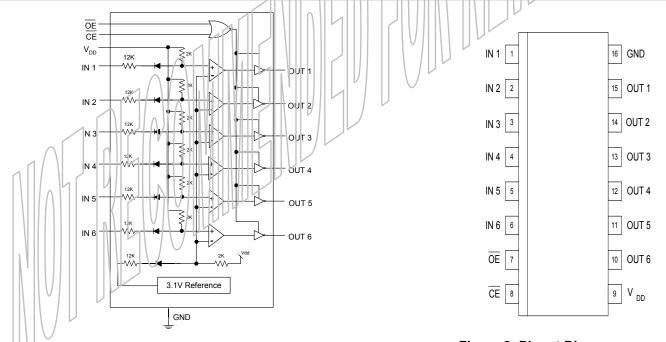


Figure 1: Function Diagram Figure 2: Pinout Diagram

Table 1: Absolute Maximum Ratings					
PARAMETER		MIN	MAX	UNITS	
Supply Voltage V _{DD}		-0.3	7.0	V	
Discrete Input Voltage (Pins 1-6)		-5	+40 *	V	
Digital Input Voltage (CE and OE)		V _{SS} - 0.3	V _{DD} + 0.3	V	
Lightning Protection (Pins 1-6) DO160D, Waveform 3; Level 3 DO160D, Waveforms 4, and 5; Level	13	-600 -300	+600 +300	V	
Junction Temperature			145	°C	
Storage Temperature	Plastic Ceramic	-55 -55	150 150	°C	
Operating Free Air Temperature	Plastic Ceramic	-55 -55	85 125	°C	

The DEI1026 contains circuitry to protect inputs from damage due to electrostatic discharge. It has been characterized per JEDEC A114-A Human Body Model to Class 1. Observe precautions for handling and storing Electrostatic Sensitive Devices.

Table 2: DEI1026 Device Operating Characteristics						
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Supply Voltage	V_{DD}		4.5	5.0	5.5	V
Free Air Operating Temp.	T _A	V _{DD} = 4.5 – 5.5 V Plastic Ceramic	-55 -55		85 125	°C
Logic Output Sink Current	I _{OL}	$V_{DD} = 4.5 - 5.5 \text{ V}$			5.0	mA
Logic Output Source Current	I _{OH}	$V_{DD} = 4.5 - 5.5 \text{ V}$	-5.0			mA

Table 3: DEI1026 Logic Truth Table						
CE (Chip Enable)	Output					
0	0	Open	0			
0	0	Ground	1			
1	X	X	High Z			
X	1	X	High Z			

^{*} The DEI1026 will withstand the transient surge DC voltage step function loci limits for category B equipment per MIL-STD-704A.

Table 4A: DEI1026-SES (Plastic) Electrical Characteristics $(T_A = -55^{\circ}\text{C to } +85^{\circ}\text{C}, \ V_{DD} = 4.5 \text{ to } 5.5 \text{ V}, \ \text{Unless otherwise noted})$								
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS		
	Power Supply Characteristics							
Supply Current	I _{DD}	$V_{IN} = V_{DD}$ (all inputs) $V_{DD} = 5.5 \text{ V}$		5	10	mA		
Discrete Input Characteristics								
Ground state input voltage	V_{SG}	Voltage source from input terminal to ground for Logic High Output.			3.0	V		
Open state input voltage	V _{SO}	Voltage source from input terminal to ground for Logic Low Output.	3.5			V		
Ground state input resistor	R _{IG}	Resistor from input to ground to guarantee Logic High Output.	0		100	Ω		
Open state input resistor	R _{IO}	Resistor from input to ground to guarantee Logic Low Output.	100k			Ω		
Input source current	I _{IO}	Current sourced into 100 Ohm resistor to Ground.	-100	-330		μΑ		
Reverse leakage current	I _{IR}	V _{IN} = 35 V, V _{DD} = 0 V			100	μА		
		Logic Input Characteristics						
CE, OE input logic 1 level	V _{IH}		2.0			V		
CE, OE input logic 0 level	V _{IL}				0.8	V		
		DC Output Characteristics	1					
Output logic 1 level (TTL)	V _{OH}	I _{OH} = -5 mA	2.4			V		
Output logic 0 level (TTL)	V _{OL}	I _{OL} = 5 mA (2)			0.4	V		
Output logic 1 level (CMOS)	V _{OH}	I _{OH} = -100 μA	V _{DD} – 50mV			V		
Output logic 0 level (CMOS)	V _{OL}	Ι _{ΟL} = 100 μΑ			V _{SS} + 50mV	V		
Off-state Output Current	l _{oz}	$ \overline{OE} = V_{DD} V_{DD} = 5.5 V V_{OUT} = 0 \text{ or } V_{DD} $			+/-10	μА		
Switching Characteristics [1]								
I/O propagation delay	t _{HL} , t _{LH}	Refer to Figure 4.			150	ns		
Delay from CE or OE input (with output low) to output HI-Z	t _{LZ}	Refer to Figure 3.			25	ns		
Delay from CE or OE input (with output HI-Z) to output low	t _{zL}	Refer to Figure 3.			25	ns		
Delay from CE or OE input (with output high) to output HI -Z	t _{HZ}	Refer to Figure 3.			25	ns		
Delay from CE or OE input (with output HI-Z) to output high	t _{zH}	Refer to Figure 3.			25	ns		

Table 4B: DEI1026-WM[] (Ceramic) Electrical Characteristics ($T_A = -55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, $V_{DD} = 4.5$ to 5.5 V, Unless otherwise noted)									
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS			
Power Supply Characteristics									
Supply Current	I _{DD}	$V_{IN} = V_{DD}$ (all inputs) $V_{DD} = 5.5 \text{ V}$		5	10	mA			
	Discrete Input Characteristics								
Ground state input voltage	V _{SG}	Voltage source from input terminal to ground for Logic High Output.			3.0	V			
Open state input voltage	V _{SO}	Voltage source from input terminal to ground for Logic Low Output.	3.5			V			
Ground state input resistor	R _{IG}	Resistor from input to ground to guarantee Logic High Output.	0		100	Ω			
Open state input resistor	R _{IO}	Resistor from input to ground to guarantee Logic Low Output.	100k			Ω			
Input source current	I _{IO}	Current sourced into 100 Ohm resistor to Ground.	-100	-330		μΑ			
Reverse leakage current	I _{IR}	$V_{IN} = 35 \text{ V}, \ V_{DD} = 0 \text{ V}$			100	μΑ			
	Lo	gic Input Characteristic	cs						
CE, OE input logic 1 level	V _{IH}		2.0			V			
CE, OE input logic 0 level	V _{IL}				0.8	V			
	D	C Output Characteristic	s						
Output logic 1 level (TTL)	V_{OH}	I _{OH} = -5 mA	2.4			V			
Output logic 0 level (TTL)	V _{OL}	I _{OL} = 5 mA (2)			0.4	V			
Output logic 1 level (CMOS)	V _{OH}	I _{OH} = -100 μA	$V_{DD} - 50 \text{mV}$			V			
Output logic 0 level (CMOS)	V _{OL}	I _{OL} = 100 μA			V _{SS} + 50mV	V			
Off-state Output Current	l _{oz}	\overline{OE} = V _{DD} V _{DD} = 5.5 V V _{OUT} = 0 or V _{DD}			+/-10	μΑ			
	Switching Characteristics [1]								
I/O propagation delay	t _{HL} , t _{LH}	Refer to Figure 4.			170	ns			
Delay from CE or OE input (with output low) to output HI-Z	t _{LZ}	Refer to Figure 3.			30	ns			
Delay from CE or OE input (with output HI-Z) to output low	t _{ZL}	Refer to Figure 3.			30	ns			
Delay from CE or OE input (with output high) to output HI -Z	t _{HZ}	Refer to Figure 3.			30	ns			
Delay from CE or OE input (with output HI-Z) to output high	t _{zH}	Refer to Figure 3.			30	ns			

Notes:

- Guaranteed by design and not production tested.
 Limit the sum of all IOL currents to 20ma. The Vsg spec may exceed limit beyond this current.

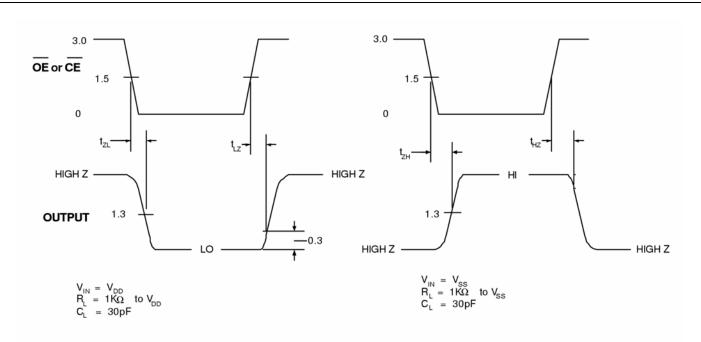


Figure 3: Enable to Output Propagation Delay

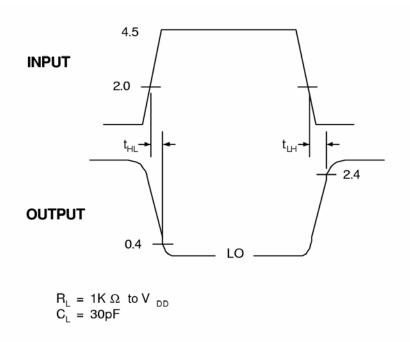
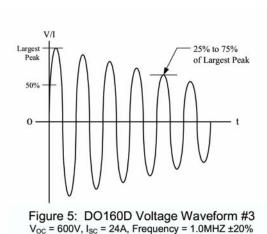


Figure 4: Input to Output Propagation Delay



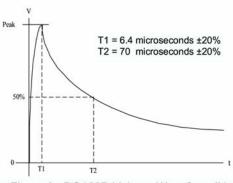
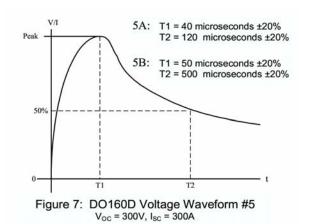


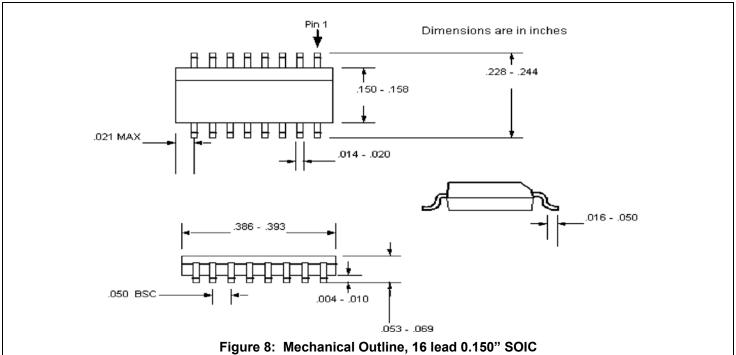
Figure 6: DO160D Voltage Waveform #4 Voc = 300V, I_{SC} = 60A



Notes:

- Voc = Peak Open Circuit Voltage available at the calibration point.
- Isc = Peak Short Circuit Current available at the calibration point.
- 3. Amplitude tolerances: +10%, -0%
- The ratio of Voc to Isc is the generator source impedance to be used for generator calibration purposes.

Table 5: Package Characteristics					
PACKAGE TYPE	16 Lead SOIC Narrow Body	16 Lead SOIC Narrow Body, Green	16 Lead Ceramic SOP		
REFERENCE	16L SOIC NB	16L SOIC NB G	16L CSOP		
THERMAL RESISTANCE:					
θ_{JA} (4 layer PCB with Power Planes)	74 °C/W	74 °C/W	-		
$\theta_{ m JC}$	24 °C/W	24 °C/W	23 °C/W		
JEDEC MOISTURE SENSITIVITY LEVEL (MSL)	MSL 2 / 235°C	MSL 2 / 260°C	Hermetic		
LEAD FINISH MATERIAL / JEDEC Pb-free CODE	SnPb	NiPdAu e4	Au e4		
Pb-Free DESIGNATION	Not Pb-free	RoHS Compliant	Pb Free		
JEDEC REFERENCE	MS-012-AC	MS-012-AC	-		



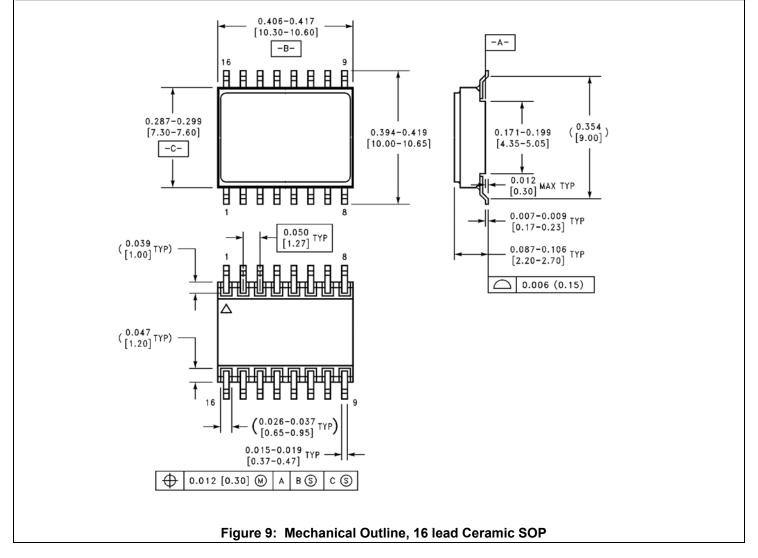


Table 6: Ordering Information							
DEI PART NUMBER	MARKING (1)	PACKAGE	OP. TEMP. RANGE	PROCESSING			
DEI1026	DEI1026	16L SOIC NB	-55 / +85°C	Standard			
DEI1026-G	DEI1026 E4 (2)	16L SOIC NB G	-55 / +85°C	Standard			
DEI1026-WMS	DEI1026-WMS	16 lead ceramic SOP	-55 / +125°C	Standard			
DEI1026-WMB	DEI1026-WMB	16 lead ceramic SOP	-55 / +125°C	Burn In, 96 hr @125°C			

NOTES:

- 1. All packages marked with Lot Code and Date Code.
- 2. "E4" after Date Code Denotes Pb Free category.

DEI reserves the right to make changes to any products or specifications herein. DEI makes no warranty, representation, or guarantee regarding suitability of its products for any particular purpose.